

AUTOMOTIVE GRADE

AUIRFZ44VZS

HEXFET® Power MOSFET

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching

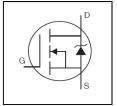
Description

of other applications

Repetitive Avalanche Allowed up to Timax

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety

- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}	60V
R _{DS(on)} typ.	9.6mΩ
max.	12mΩ
I _D	57A



G	D	S
Gate	Drain	Source

G	D	S
Gate	Drain	Source

Bose next number Deckers Type		Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
ALUDE744\/70	D ² -Pak	Tube	50	AUIRFZ44VZS
AUIRFZ44VZS		Tape and Reel Left	800	AUIRFZ44VZSTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	57	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	40	Α
I _{DM}	Pulsed Drain Current ①	230	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	92	W
	Linear Derating Factor	0.61	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS (Thermally Limited)}	Single Pulse Avalanche Energy (Thermally Limited) ②	73	m l
E _{AS (Tested)}	Single Pulse Avalanche Energy (Tested Limited) ®	110	mJ
I _{AR}	Avalanche Current ①	See Fig. 12a, 12b, 15, 16	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
$T_{\rm J}$	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		1.64	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D² Pak ⑦		40	C/VV

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^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.061		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		9.6	12	mΩ	V _{GS} = 10V, I _D = 34A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	25			S	$V_{DS} = 25V, I_{D} = 34A$
	Design to Course I column Current			20		$V_{DS} = 60V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	- A	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

		-	-		
Total Gate Charge		43	65		I _D = 34A
Gate-to-Source Charge		11		nC	$V_{DS} = 48V$
Gate-to-Drain Charge		18			V _{GS} = 10V ③
Turn-On Delay Time		14			$V_{DD} = 30V$
Rise Time		62		no	$I_D = 34A$
Turn-Off Delay Time		35		HS	$R_G = 12\Omega$
Fall Time		38			V _{GS} = 10V ③
Internal Drain Inductance		4.5		nЦ	Between lead, 6mm (0.25in.)
Internal Source Inductance		7.5		11171	from package and center of die contact
Input Capacitance		1690			$V_{GS} = 0V$
Output Capacitance		270			$V_{DS} = 25V$
Reverse Transfer Capacitance		130		_	f = 1.0MHz
Output Capacitance		1870		p⊦	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
Output Capacitance		260			$V_{GS} = 0V, V_{DS} = 48V, f = 1.0MHz$
Effective Output Capacitance		510			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V$
	Gate-to-Source Charge Gate-to-Drain Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Internal Source Inductance Input Capacitance Output Capacitance Reverse Transfer Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance	Gate-to-Source Charge —— Gate-to-Drain Charge —— Turn-On Delay Time —— Rise Time —— Turn-Off Delay Time —— Fall Time —— Internal Drain Inductance —— Internal Source Inductance —— Input Capacitance —— Output Capacitance ——	Gate-to-Source Charge — 11 Gate-to-Drain Charge — 18 Turn-On Delay Time — 14 Rise Time — 62 Turn-Off Delay Time — 35 Fall Time — 38 Internal Drain Inductance — 4.5 Internal Source Inductance — 7.5 Input Capacitance — 1690 Output Capacitance — 130 Output Capacitance — 1870 Output Capacitance — 260	Gate-to-Source Charge — 11 — Gate-to-Drain Charge — 18 — Turn-On Delay Time — 14 — Rise Time — 62 — Turn-Off Delay Time — 35 — Fall Time — 38 — Internal Drain Inductance — 4.5 — Internal Source Inductance — 7.5 — Input Capacitance — 1690 — Output Capacitance — 130 — Output Capacitance — 1870 — Output Capacitance — 260 —	Gate-to-Source Charge — 11 — nC Gate-to-Drain Charge — 18 — Turn-On Delay Time — 14 — Rise Time — 62 — Turn-Off Delay Time — 35 — Fall Time — 38 — Internal Drain Inductance — 4.5 — Internal Source Inductance — 7.5 — Input Capacitance — 1690 — Output Capacitance — 270 — Reverse Transfer Capacitance — 130 — Output Capacitance — 1870 — Output Capacitance — 260 —

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			57	_	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			230		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 34A, V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		23	35	ns	$T_J = 25^{\circ}C$, $I_F = 34A$, $V_{DD} = 30V$
Q_{rr}	Reverse Recovery Charge		17	26	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsic	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\rm S}$ + $L_{\rm D}$)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)
- ② Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.12mH, $R_G = 25\Omega$, $I_{AS} = 34$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- 3 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- \oplus C_{oss eff.} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population. 100% tested to this value in production, starting $T_J = 25$ °C, L = 0.12mH, $R_G = 25\Omega$, $I_{AS} = 34$ A, $V_{GS} = 10$ V.
- This is applied to D²Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994..



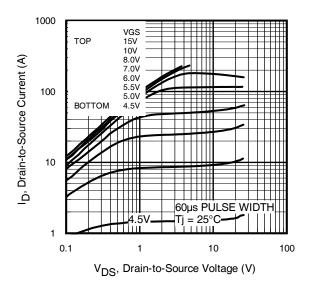


Fig. 1 Typical Output Characteristics

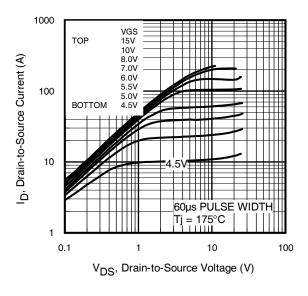


Fig. 2 Typical Output Characteristics

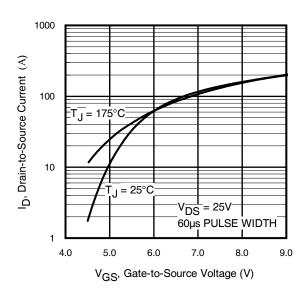


Fig. 3 Typical Transfer Characteristics

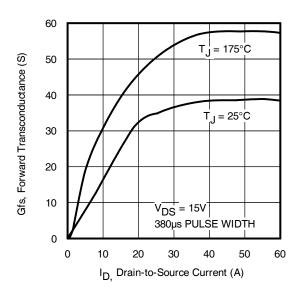


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



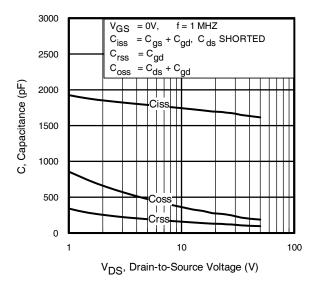


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

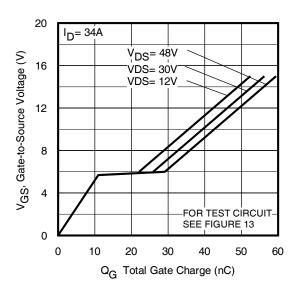


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

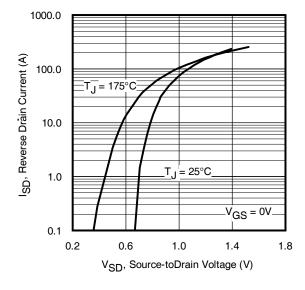


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

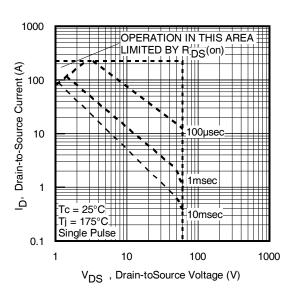


Fig 8. Maximum Safe Operating Area



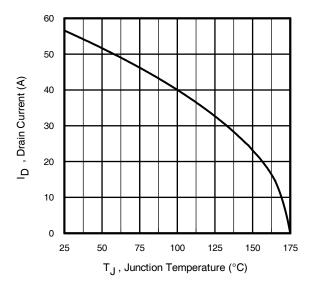


Fig 9. Maximum Drain Current Vs. Case Temperature

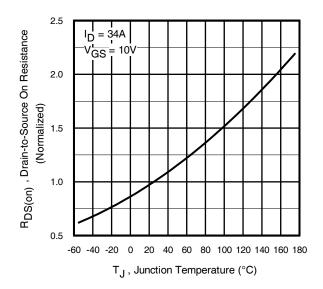


Fig 10. Normalized On-Resistance Vs. Temperature

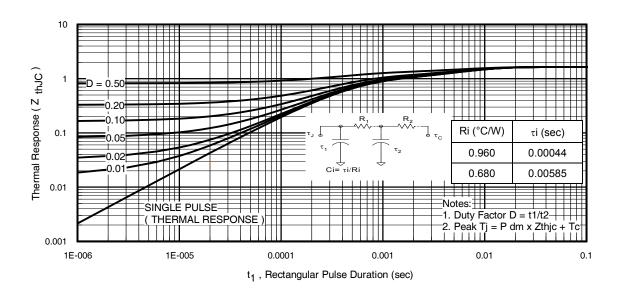


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



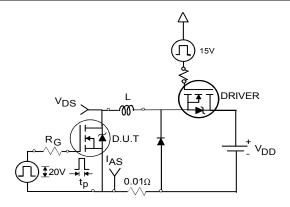


Fig 12a. Unclamped Inductive Test Circuit

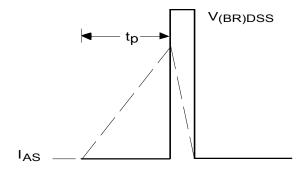


Fig 12b. Unclamped Inductive Waveforms

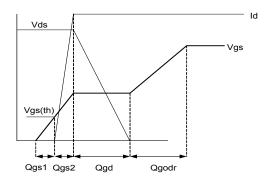


Fig 13a. Gate Charge Waveform

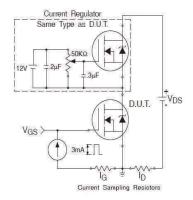


Fig 13b. Gate Charge Test Circuit

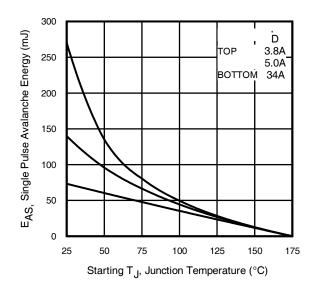


Fig 12c. Maximum Avalanche Energy vs. Drain Current

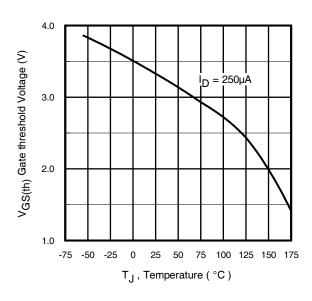


Fig 14. Threshold Voltage Vs. Temperature



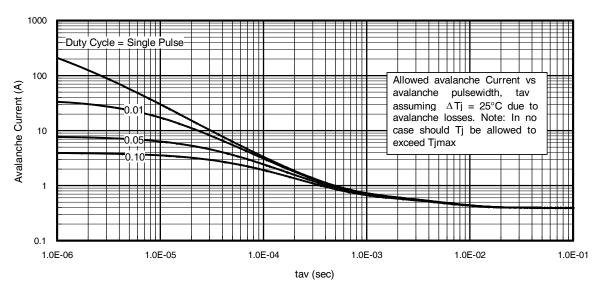
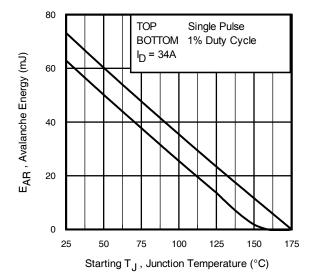


Fig 15. Typical Avalanche Current Vs. Pulse width



Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - tav = Average time in avalanche.
 - D = Duty cycle in avalanche = tav ·f
 - ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T/ \; Z_{thJC} \\ I_{av} &= 2\Delta T/ \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

Fig 16. Maximum Avalanche Energy vs. Temperature



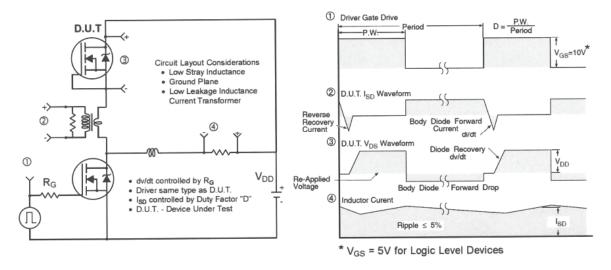


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

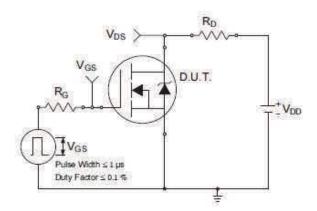


Fig 18a. Switching Time Test Circuit

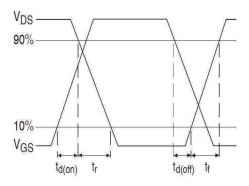
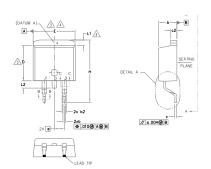
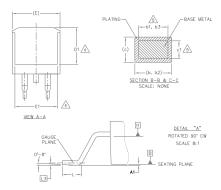


Fig 18b. Switching Time Waveforms



D²-Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H. 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S	DIMENSIONS				
M B	MILLIM	ETERS	INC	HES	O T E S
0 L	MIN.	MAX.	MIN.	MAX.	S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

DIODES

1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE 3.— ANODE

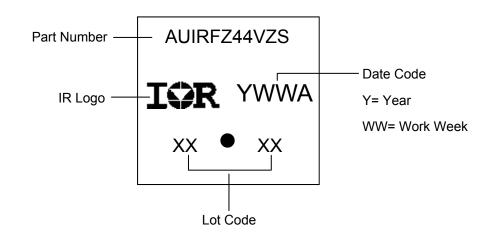
HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

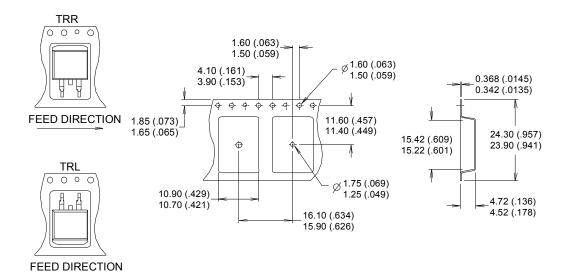
1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

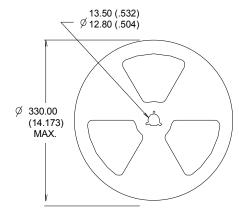
D²-Pak (TO-263AB) Part Marking Information

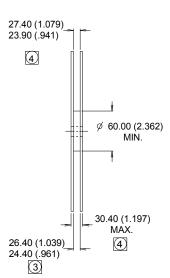




D²-Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.



Qualification Information

		Automotive (per AEC-Q101)			
Qualificat	tion Level	Comments: This part number(s) passed Automotive qualification. Infineon Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture	Sensitivity Level	D²-Pak MSL1			
	Machine Model		Class M4 (+/- 425V) [†] AEC-Q101-002		
ESD	Human Body Model		Class H1B (+/- 1000V) [†] AEC-Q101-001		
Charged Device Model		Class C5 (+/- 1125V) [†] AEC-Q101-005			
RoHS Co	mpliant	Yes			

[†] Highest passing voltage.

Revision History

Date	Comments
10/27/2015	 Updated datasheet with corporate template Corrected ordering table on page 1.
10/13/2017	Corrected typo error on part marking on page 9.

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